

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10029394	KIM ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Nguyen, Khiem D	2823	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
438	151, 197, 201, 257, 261, 288, FOR431	10/25/2007	KN
257	314, 315, E29.129, E29.3, E21.422, E21.68, E21.687, E21.688,	10/25/2007	KN
438	151,197,201,257,258,261,263	2/23/2009	/KN/
257	314,315,321,E21.422,E21.68,E21.683,E21.687,E21.688, E29.129,E29.3	2/23/2009	/KN/

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST text search updated (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	10/25/2007	KN
EAST text search updated (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	9/27/2008	/KN/
EAST text search updated (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	2/23/2009	/KN/

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/KHIEM D NGUYEN/  
Examiner.Art Unit 2823